

Detector stability (ageing, discharge issues) and rate capability: resistive electrodes

ECFA Detector R&D Roadmap Symposium of Task Force 1 Gaseous Detectors

29 April 2021

SESSION: Challenges and new developments

M. Iodice (INFN Roma Tre)

Focus of the talk

- High performance, High stability, Long term operation and High-rate capability Gaseous Detectors
- Detectors with resistive electrodes
 - RPC (see G. Aielli's talk + some hints in backup)
 - Wire Detectors: TGC and sTGC (P. Wintz' talk + some hints in backup)
 - **MPGD**

Many thanks for useful inputs to:

G. Bencivenni, G. Cibinetto, F. Fallavollita, P. Iengo, G. Mikenberg, E. Oliveri, P. Verwilligen, ...

Why resistive electrodes

High performance → **high gain** (efficiency, spatial resolution, timing,...)

High gain, often limited by onset of discharges → **Stability issues**

Occurrence of discharges due to:

- Mechanical imperfections (issues mostly for large area detectors)
- Micrometric structures in MPGD
- Transition from avalanche to streamer mode which might occur when too many primary electrons are released in the gas (exceeding the Raether limit, rate induced, jets, ...)

→ Diverging processes can be quenched by means of **resistive electrodes**.

Progressive charge-up of the anode by avalanche electrons reduces locally the electric field and quenches the spark at an early stage of development

MPGD

Micro-Pattern Gaseous Detectors (MPGD) are among the most promising technologies for gaseous particle detectors at future accelerators. Their features (see talk by E. Oliveri) can be exploited where extreme operation conditions are required.

The biggest "enemy" of standard MPGDs are the discharges. Due to the fine structure and the typical micrometric distance of their electrodes, MPGDs generally suffer from spark occurrence that can eventually damage the detector and the related FEE.

First Large size
MICROMEAS
in COMPASS

discharge rate
~0.1 discharge/s
with a beam of
 10^7 hadron/s.

D Neyret et al 2012
JINST 7 C03006

D. Thers et al., Nucl.
Instr. and Meth. A 469
(2001) 133

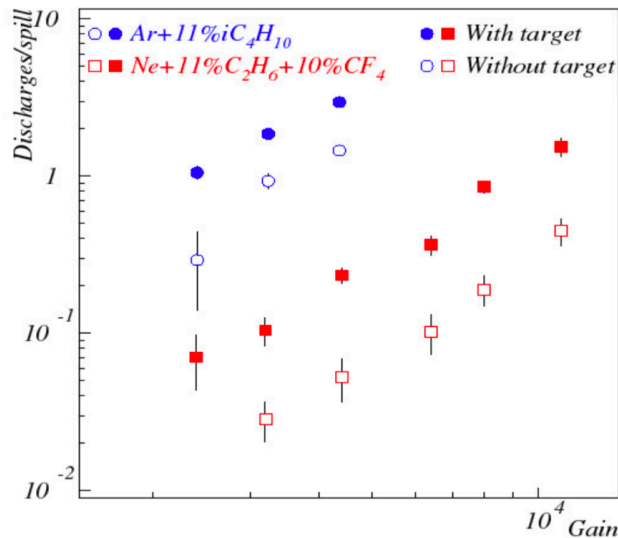
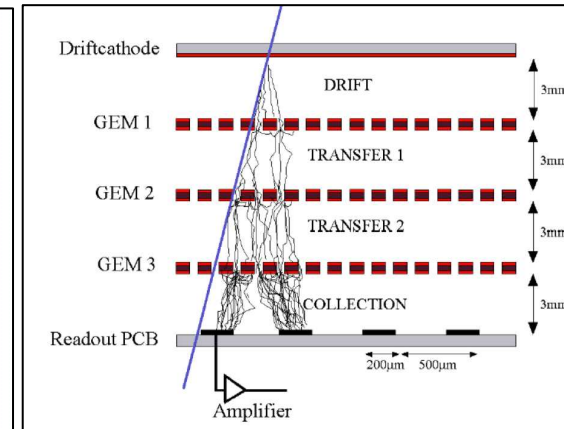
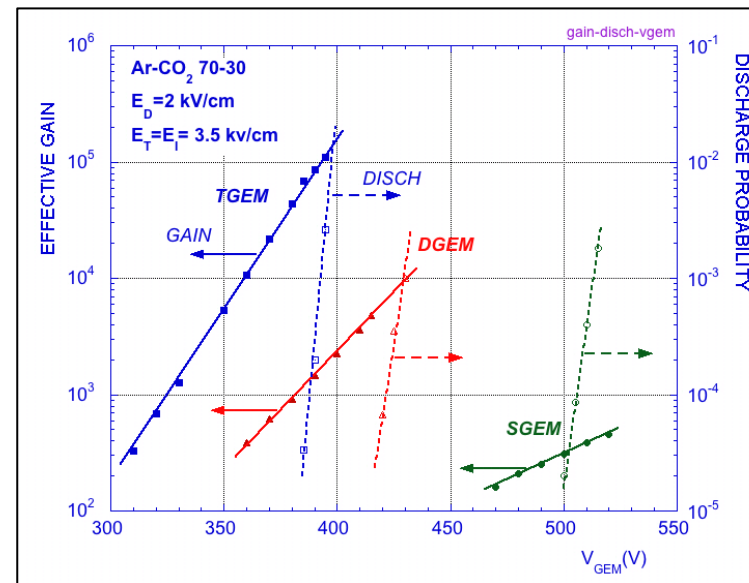


Fig. 3. Number of discharges per spill measured with the nominal COMPASS muon beam, with and without target.



S. Bachmann et al.,
NIMA A479(2002) 294

Resistive MPGD

The implementation of resistive electrodes represents the breakthrough in the MPGD technology

MAIN Goals of resistive protections:

- Drastically reduce the sparks intensity
- Improve the spatial resolution by charge spreading (not discussed here)
- Keep best “existing” MPGDs features:
 - Rate
 - Space, Time, Energy resolution
 - Low material budget



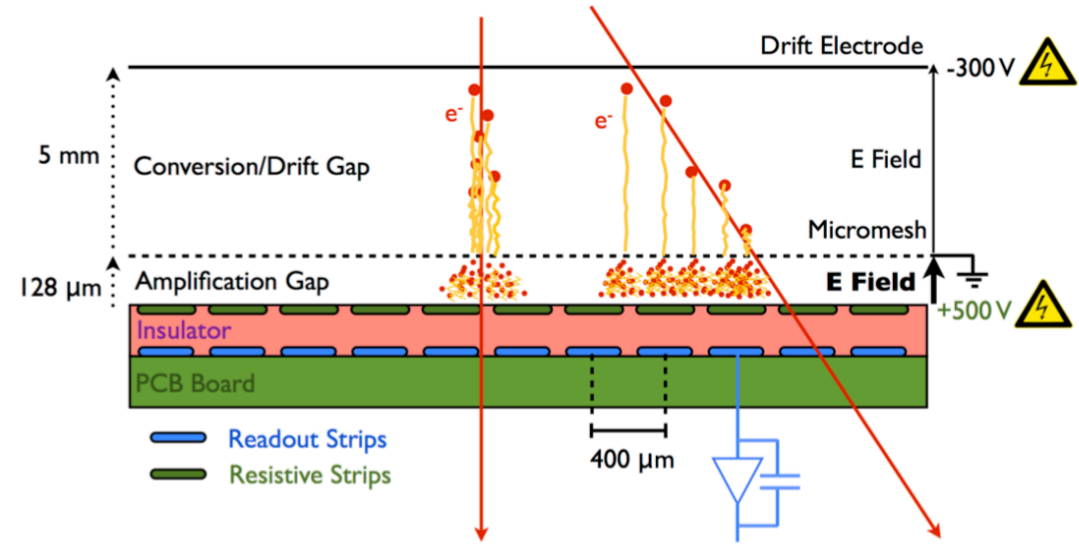
See e.g., Paul Colas “Charge spreading with a Resistive-Capacitive coating”, New Horizons in Time Projection Chambers
<https://indico.cern.ch/event/889369>

ONLY SOME EXAMPLES GIVEN IN THE FOLLOWING SLIDES

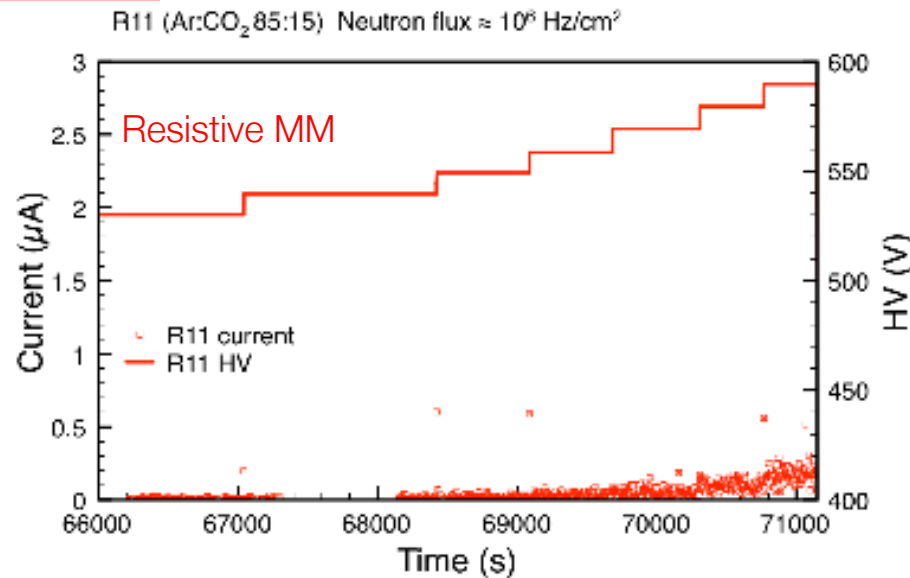
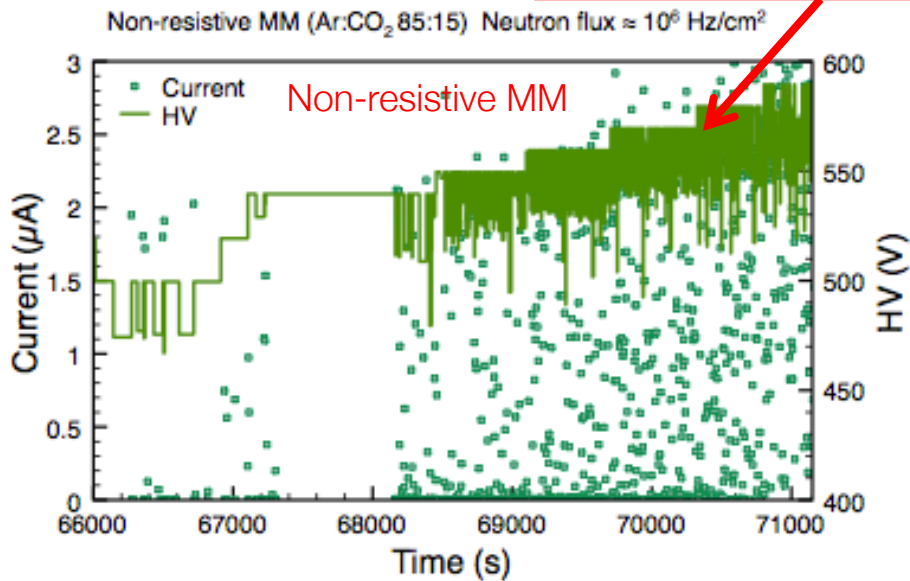
By far not exhaustive of all the great multitude of R&D currently ongoing

Resistive Micromegas – ATLAS R&D technology breakthrough

- The discharge problem has been overcome with the implementation of a layer of **resistive strips by screen printing** facing the amplification gap, capacitively coupled with the copper readout strips.
- In case of spark, the electric field locally drops down damping the discharge



voltage drop due to sparking



T.Alexopoulos et al. “A spark-resistant bulk-micromegas chamber for high-rate applications” NIM A 640 (2011) 110

Resistive Micromegas – the ATLAS Experience

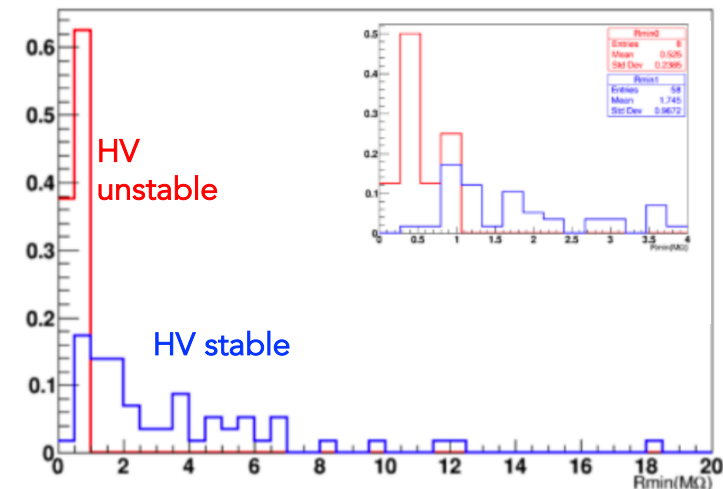
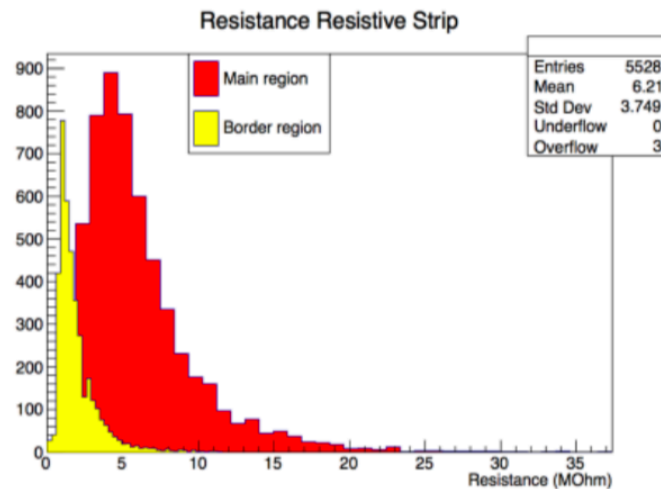
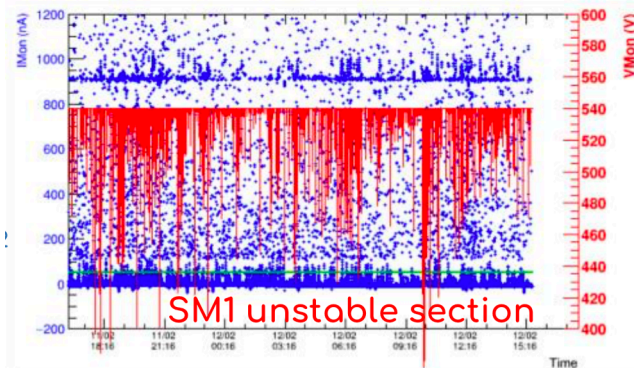
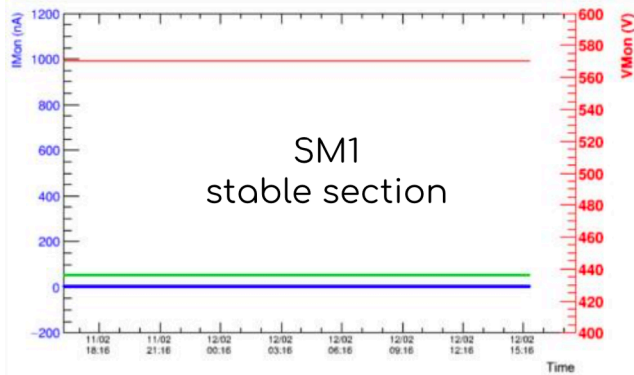
STABILITY / DISCHARGES ISSUES ...to make an extremely long story very short:

An ATLAS MM Module is divided in many HV sections. First modules showed significant issues of stabilities

Main issues identified to be:

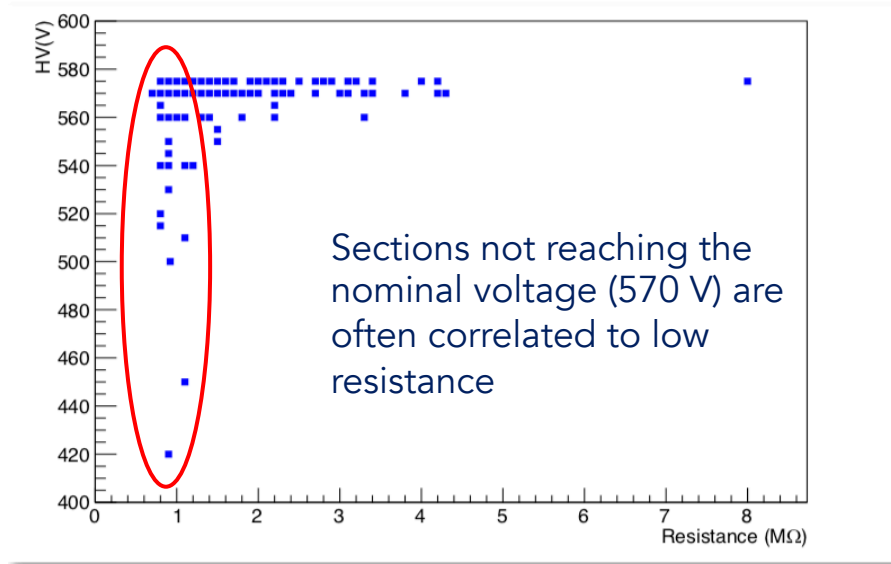
See e.g., I. Gnesi INSTR 2020

- Residual ionic contamination of boards and panels from industrial processing and handling => **improve the cleaning procedures**
- Possible effects from mesh mechanical imperfections => **implement mesh polishing**
- Clear correlation of currents with humidity => **increase gas flow rate and keep humidity under control**
- **TOO LOW RESISTANCE** in localized zones (edge of the HV section)



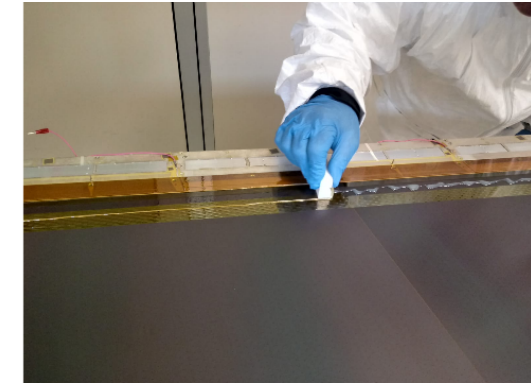
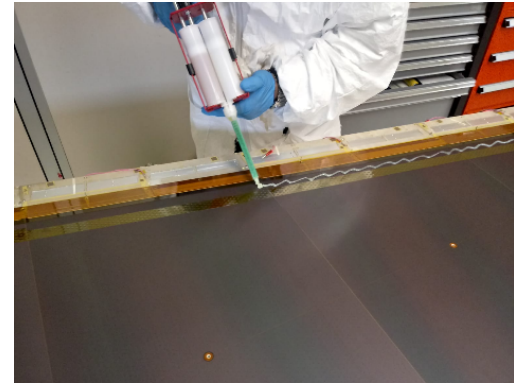
Resistive Micromegas – the ATLAS Experience

Clear correlation between unstable sectors and R_{\min}



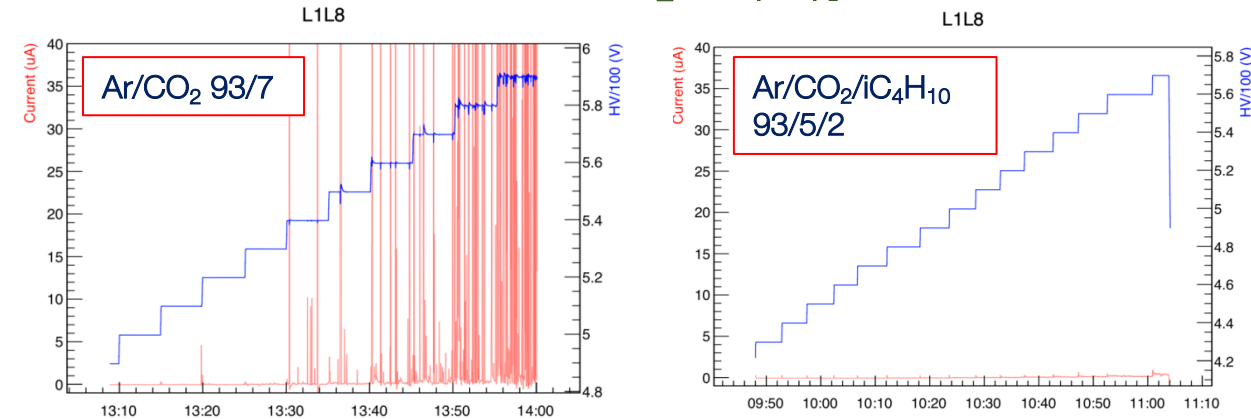
- The minimum resistance measured near the edge of the active area is sometimes very low ($R_{\min} < 0.4 \text{ M}\Omega$)
- Known effect (aka DOCA – Distance of closest approach to ground) → see G. Bencivenni et al., JINST 063P 0319
- **Lesson learned: R_{\min} , DOCA are key parameters !**

Mitigation of the problem by edge passivation



Slightly reduces the active area

NEW GAS MIXTURE: Ar/CO₂/iC₄H₁₀ 93/5/2



Much higher stability with 2% of isobutane

AGEING studies ongoing

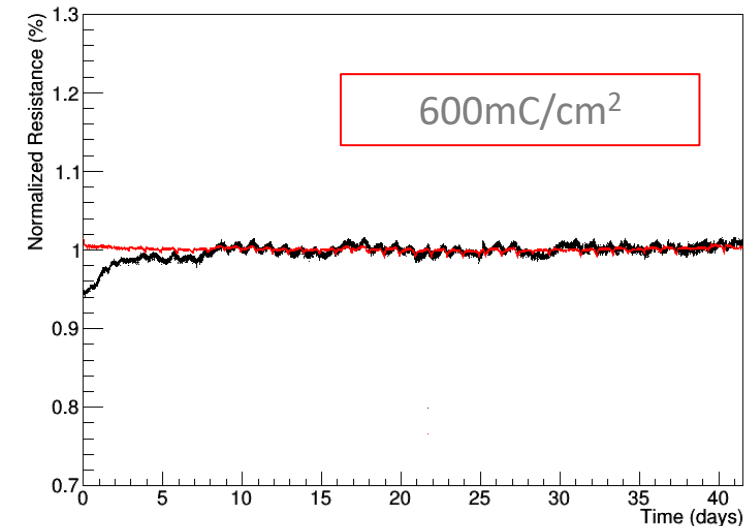
See also: G. Puill, et al., IEEE TRANS NUCL SCI, 46 (1999) 1894

Current developments on Resistive MPGD - DLC

- Diamond Like Carbon (DLC) coatings: properties of DLC have offered new possibilities opening the way to develop new detector structures.
- Stable and mechanically robust material

For DLC see also:
RD51 DLC Workshop Report
RD51-NOTE-2021-002
and references therein

DLC stability (PRC BLACK, JPN RED)



Measurements taken with bare DLC foils applying a DC Voltage in order to induce a continuous current flow over the DLC surface

Carbon dry sputtering → DLC

- ▶ Sputtered carbon
 - Diamond like, and amorphous structure
 - It means, carbon particles of molecular size!
- ▶ Fine structure with proper resistivity is available
 - with liftoff method

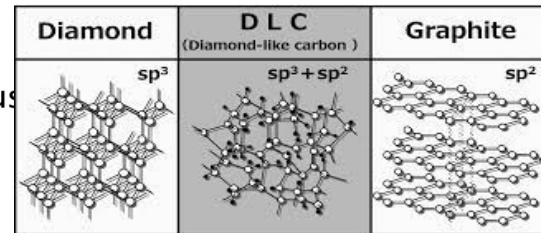
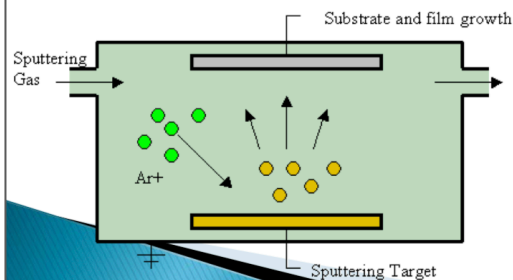


Image from Tribology International Vol 37, 11-12, p907

Random mixture of sp^3 (diamond like) and sp^2 (graphite like) carbon makes conductive paths of molecular size.

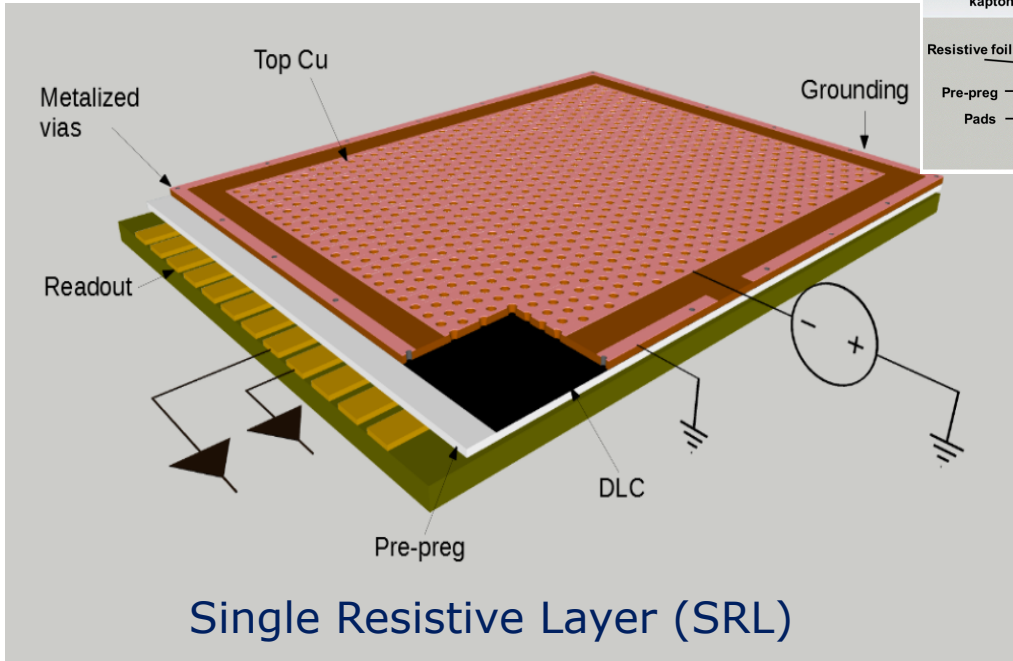


A. Ochi,
RD51 mini-week
CERN 05/12/2018

The μ -RWELL: a DLC based resistive detector

The core of a μ -RWELL detector is the μ -RWELL-PCB realized by coupling 3 elements:

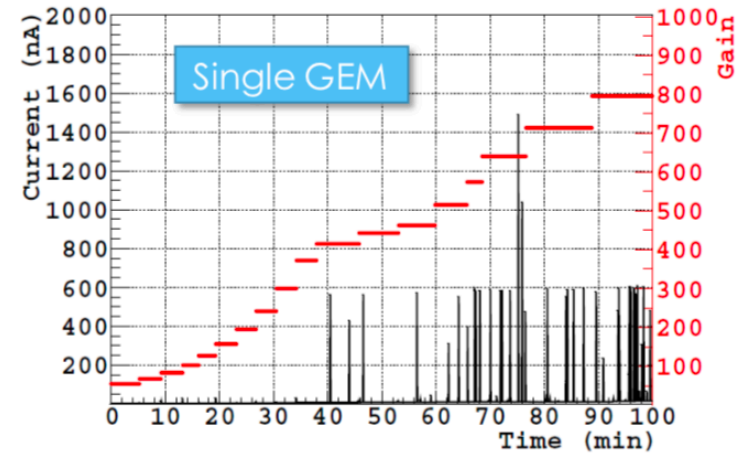
- a WELL patterned Kapton foil acting as amplification stage (GEM-like)
- a resistive DLC layer
- a standard readout PCB



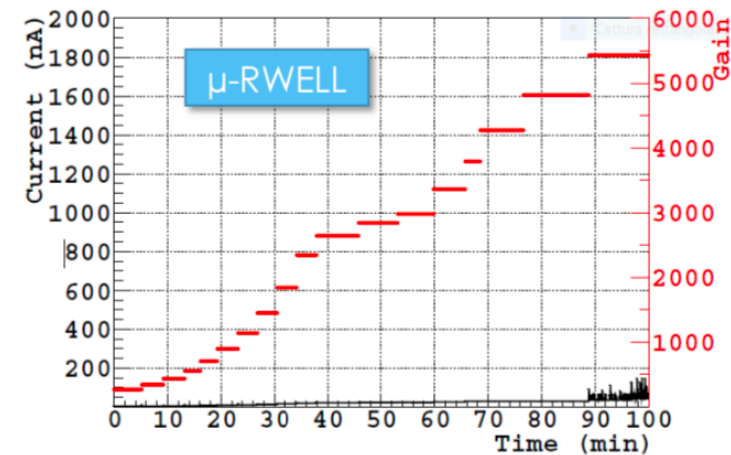
- G. Bencivenni et al., JINST 063P 0319
- M. Giovannetti at INSTR2020

- 2-D current evacuation scheme based on a single resistive layer
- conductive grounding line all around the perimeter of the active area
- Limitation for large area: the signal amplitude depends on the particle incident point \rightarrow limited rate capability - $O(10\text{kHz}/\text{cm}^2)$

Comparison between the **Current** drawn by a Single GEM and a μ RWELL at various **GAIN**

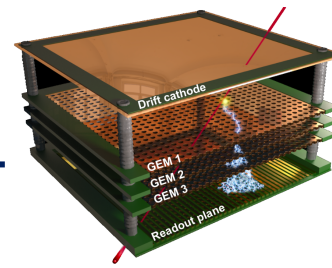


for GEM discharges are of the order of $1\mu\text{A}$ at **Gain < 1k**

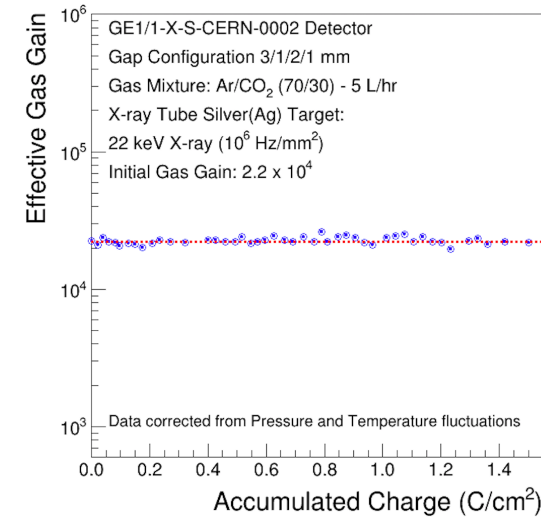


for μ -RWELL discharges are of the order of few tens of nA at **Gain > 5k**

GEM



CMS-GEM
MEO
(F. Fallavollita)

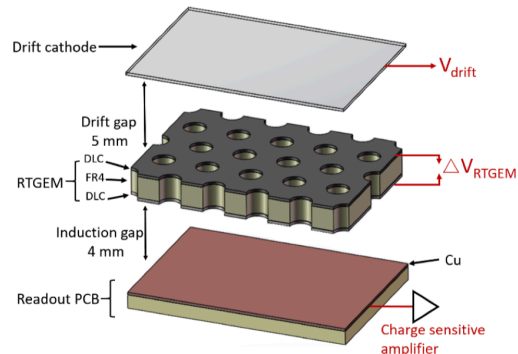


- The main solution adopted to obtain high gain, high performance with GEM is the multi-stage amplification scheme
 - E.g., Triple GEM successfully employed in many experiments and now large area 3-4-GEM under installation in CMS and ALICE (TPC) at LHC
 - Good stability, high gain ($>2 \times 10^4$), high-rate capability (100's kHz/cm²)

NO aging observed up to $\sim 1.5 \text{ C/cm}^2$

R&D on Resistive GEM (improve spark protection and reduce X0)

Resistive Thick GEM (RETGEM)



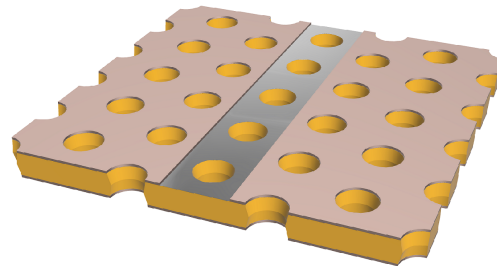
A DLC version

G. Song *et al* 2020 *JINST* 15 P11013

See also
R. Oliveira, V. Peskov, et al.
NIM A 576 (2007) 362

DLC in SECTORS SEPARATION:

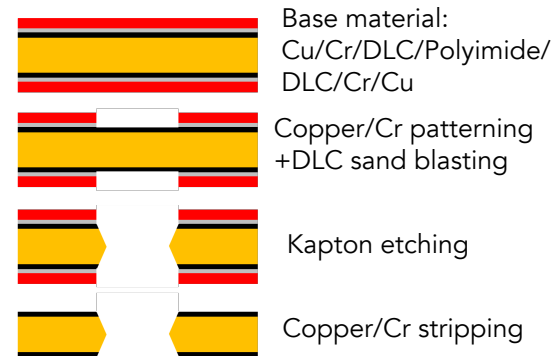
preserve the electric field line uniformity



F. Sauli "RESTORING EFFICIENCY IN GEM SECTOR SEPARATIONS"
<https://indico.cern.ch/event/843711/>
And A.P. Marques, et al. *NIM A* 961 (2020) 163673

ONGOING R&D

Full DLC GEM

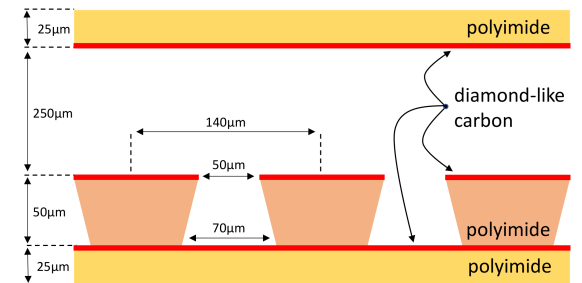


Still **ISSUES** with low adhesion of Cr on DLC

R. De Oliveira, RD51 October 2019
<https://indico.cern.ch/event/843711111>

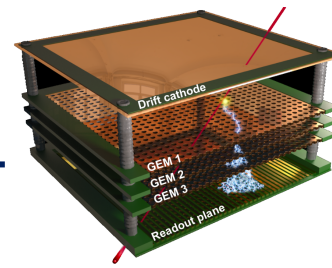
FTM Fast Timing Mpgd

(see talk by P. Verwilligen)

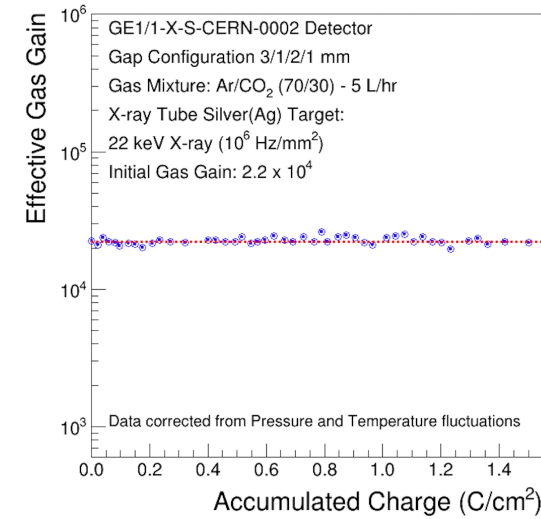


FTM effort: Full resistive kapton 50 μm with DLC
Next step: GEM

GEM



CMS-GEM
MEO
(F. Fallavollita)

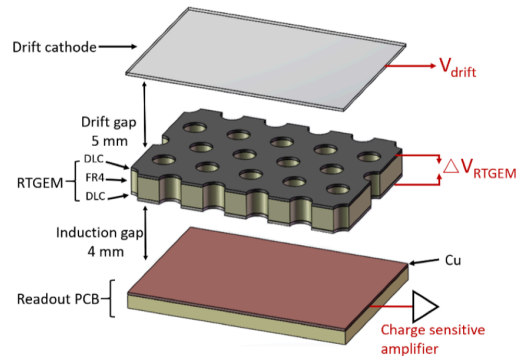


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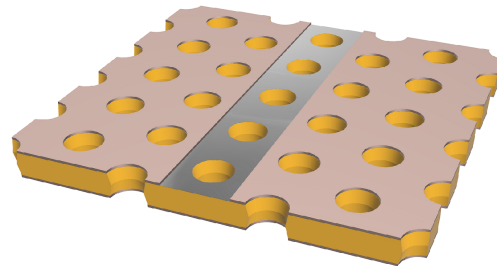
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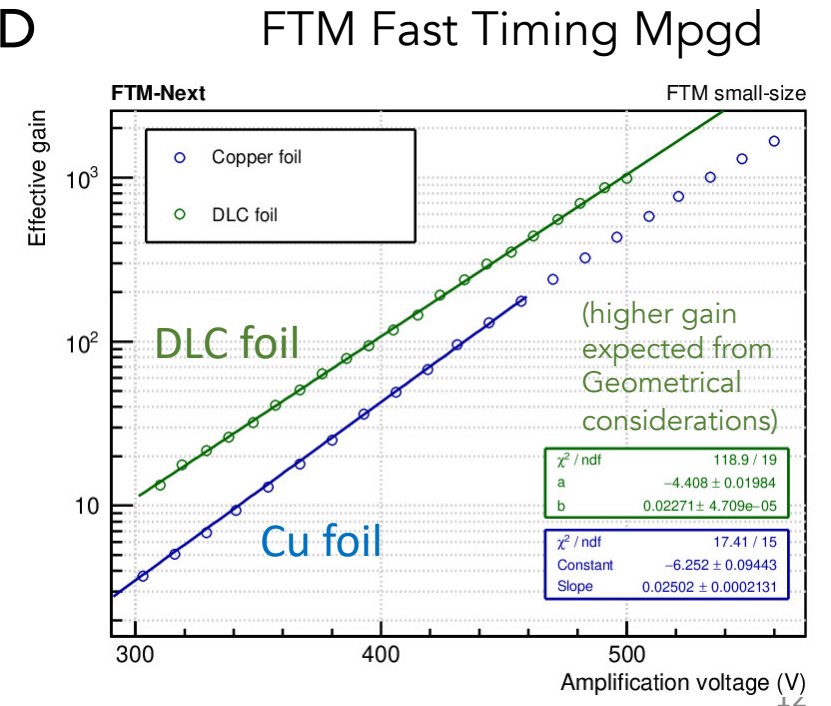
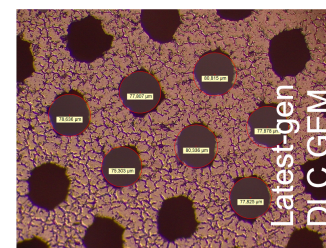
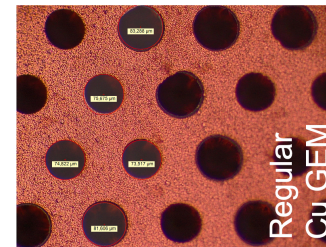
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And A.P. Marques, et al. *NIM A* 961 (2020) 163673

ONGOING R&D Full DLC GEM



Challenges for future R&D on resistive MPGD

- **HIGH RATE:** Stable and efficient operation up to particle fluxes of **10 MHz/cm²** (and beyond)
- Radiation hard and effective **spark quenching** up to integrated charges of **tens of C/cm²**
- **Low occupancy:** high granularity readout to operate efficiently at high rate
 - Pixels/pads readout of order of **few mm²**
 - fully **integrated electronics**
- **High gain** for improved performance, single-electron detection & Fast Timing
- **Good spatial resolution** (~50um and below)

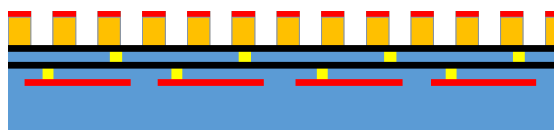
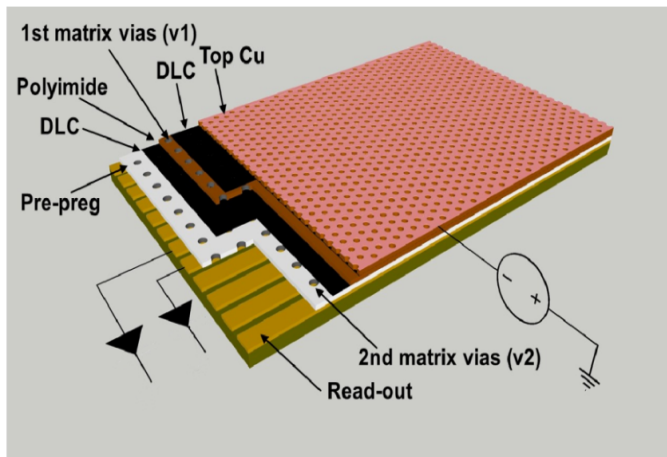
...and... **Gas optimisation, Fast timing, Improved Electronics, Low material budget, Reliable and cost-effective** production process

Resistive schemes for HIGH RATES

Resistive electrodes are inherently **unsuitable for HIGH RATES** (ohmic voltage drop).
 Need to develop new, more complex resistive schemes, eventually implementing standard techniques of PCB production

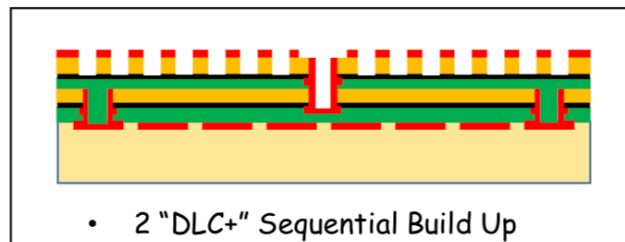
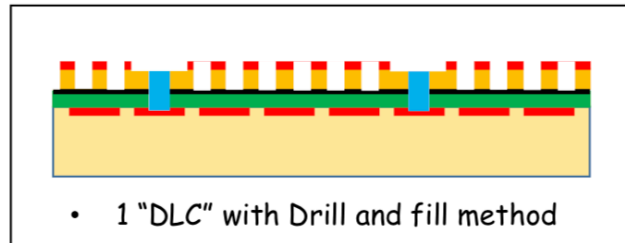
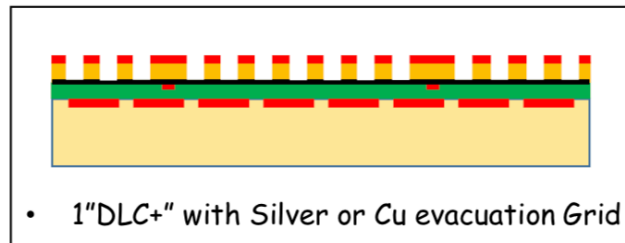
- Keep sufficient local surface resistivity to quench sparks
- with low resistance to grounding

Double DLC μ Rwell

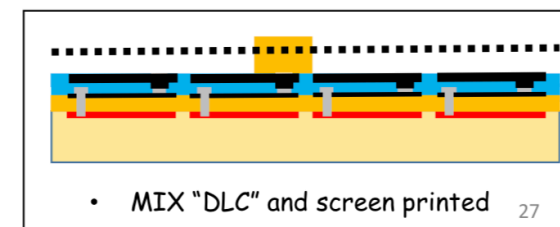
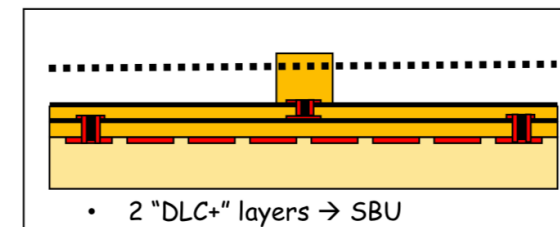
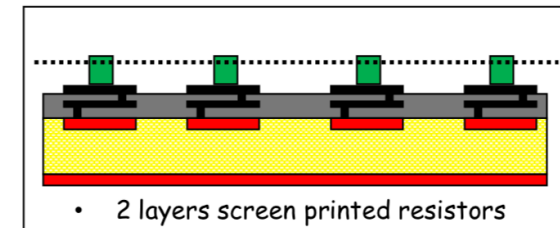


Concept of the Double DLC layer with conductive vias to ground every few mm

Different μ Rwell structures



Different Resistive protection approach with SMALL PAD Micromegas



DLC+ is a DLC with Cu/Cr coating allowing for standard lithographic production (backup slide)

Pad-patterned schemes – the embedded resistor approach

Schemes with fully independent pads offer several advantages:

- Very high rates
- Resistance independent from the position
→ constant behaviour as a function of irradiated area

1. Resistive Micromegas for SDCAL (pads 10x10 mm²)

(M. Chefdeville et al., NIM A (2021) 510–511)

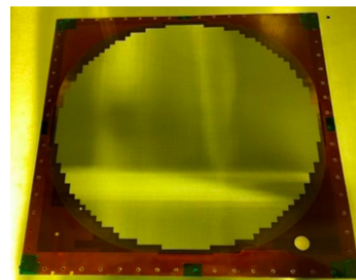
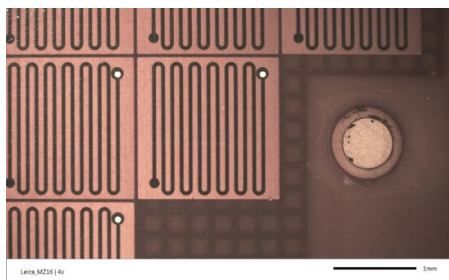
2. Pad miniaturisation for COMPASS R&D (pads 0.7x2.6 mm²)

(F. Thibaud et al., 2014 JINST 9 C02005)

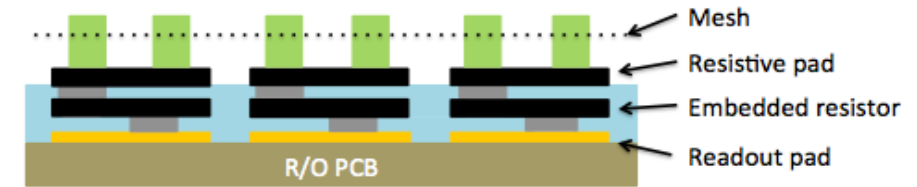
3. Small Pads MM – improving COMPASS R&D new resistive schemes (0.8 x 2.8 mm²) (M. Alviggi, JINST 12 C03077 (2017))

Screen printing

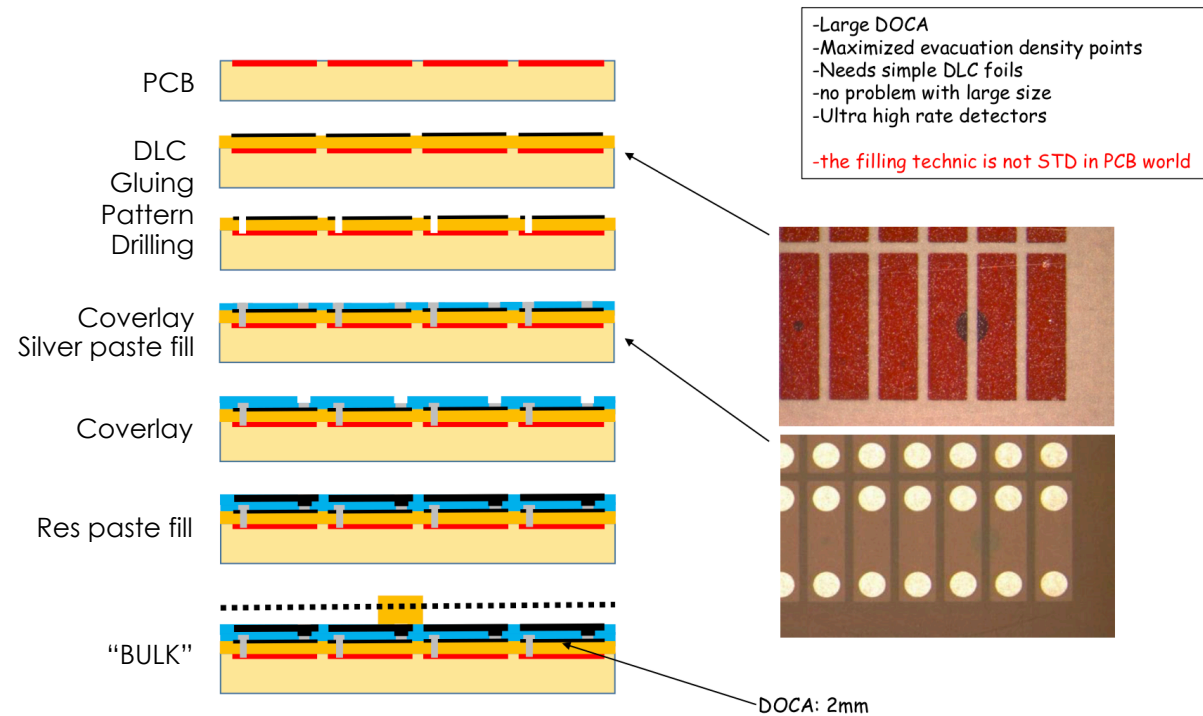
Shapes (Resistance) defined by photolithographic processes



5 ILC DHCAL
50cm diameter
pads 1cm x 1cm
5M/Pad



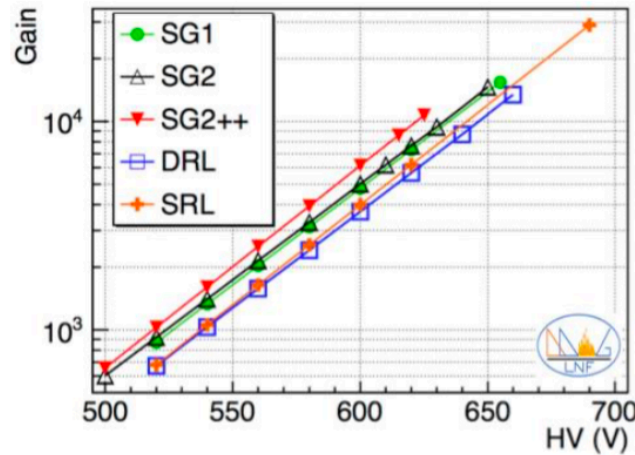
MIX method: DLC+paste filling



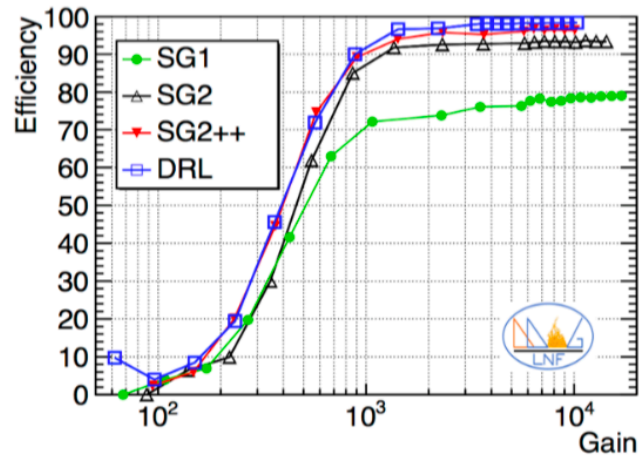
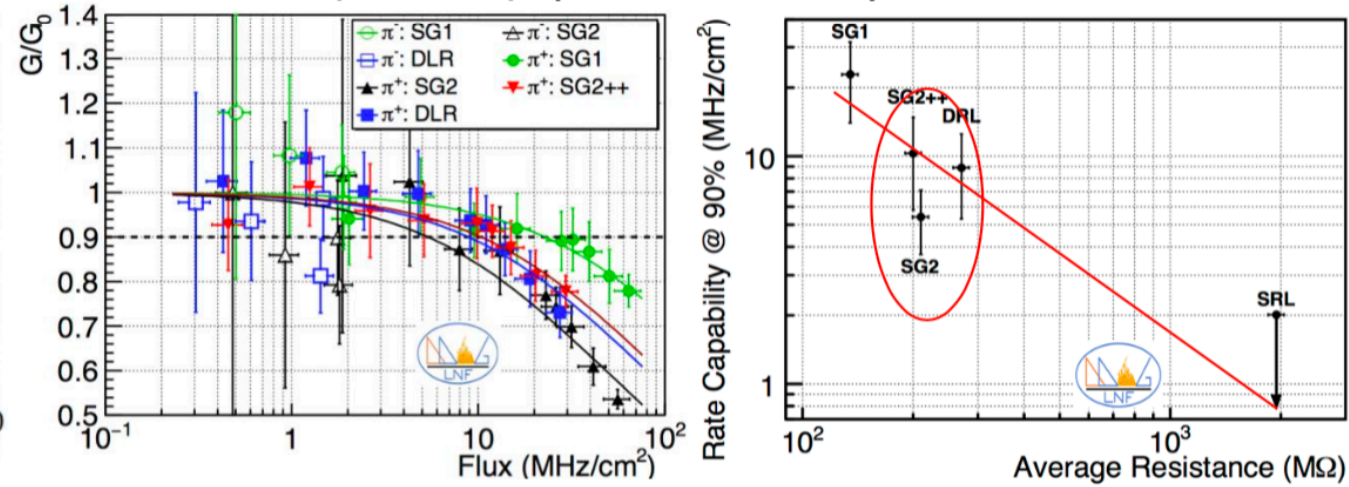
PERFORMANCE - μ RWell

• M. Giovannetti at INSTR2020

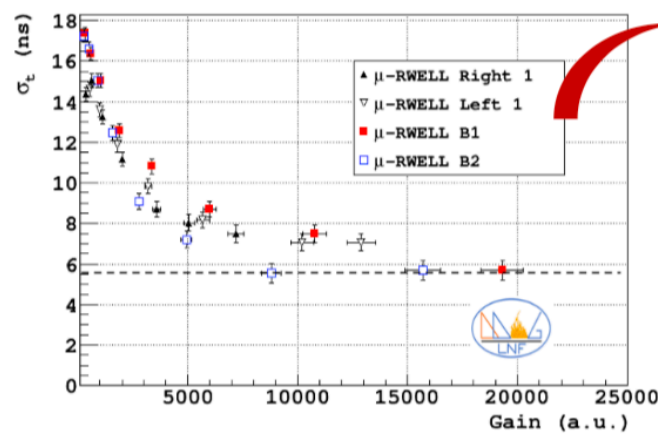
Gain up to $\sim 10^4$



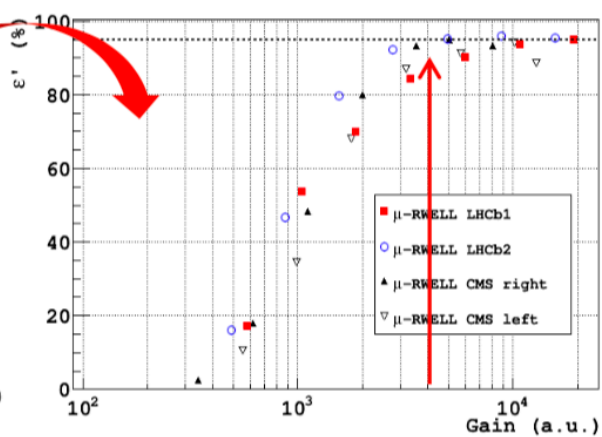
Rate capability (@ $G = 5000$) $\sim 5-10$ MHz/cm 2



Efficiency $\sim 98\%$



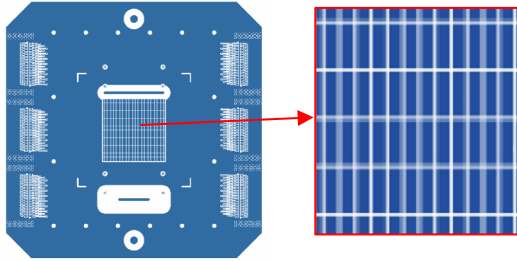
$\sigma_t \sim 5-6$ ns



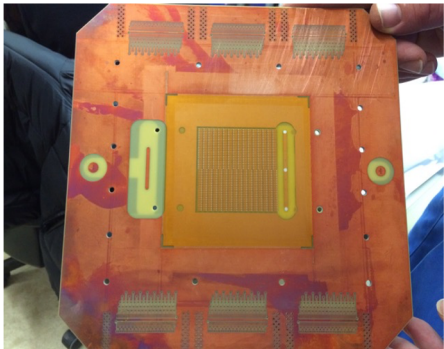
Efficiency in 25 ns

PERFORMANCE – High-rate High-granularity Micromegas

ONGOING R&D

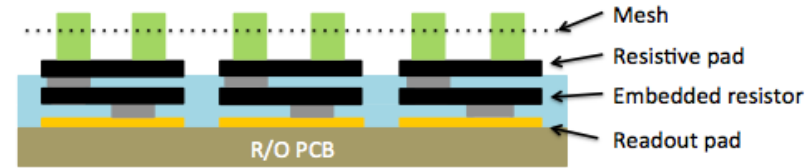


Pixelated readout pads of $0.8 \times 2.8 \text{ mm}^2$

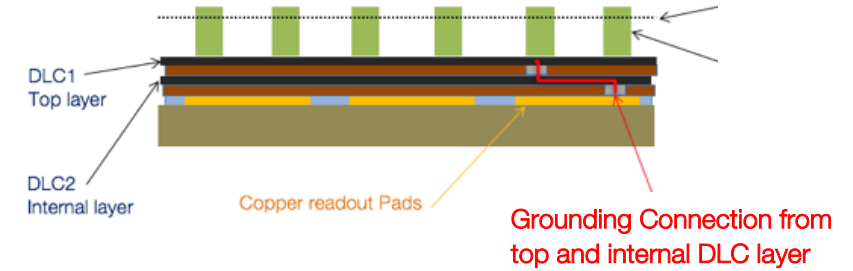


- M. Alviggi, et al. JINST 12 C03077 (2017)
- M. Iodice at INSTR 2020, and RD51 mini-week 15-19 February 2021

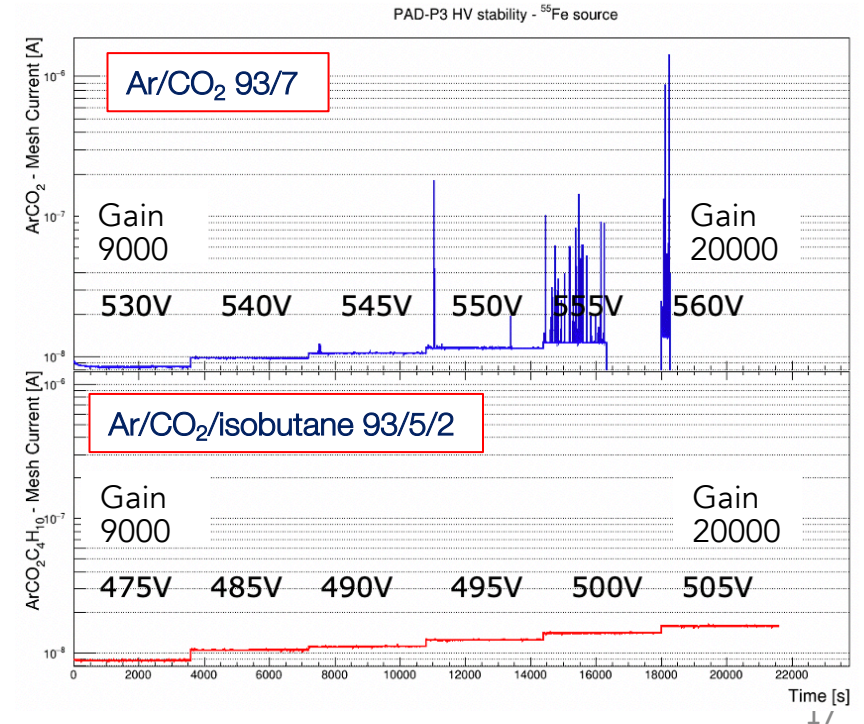
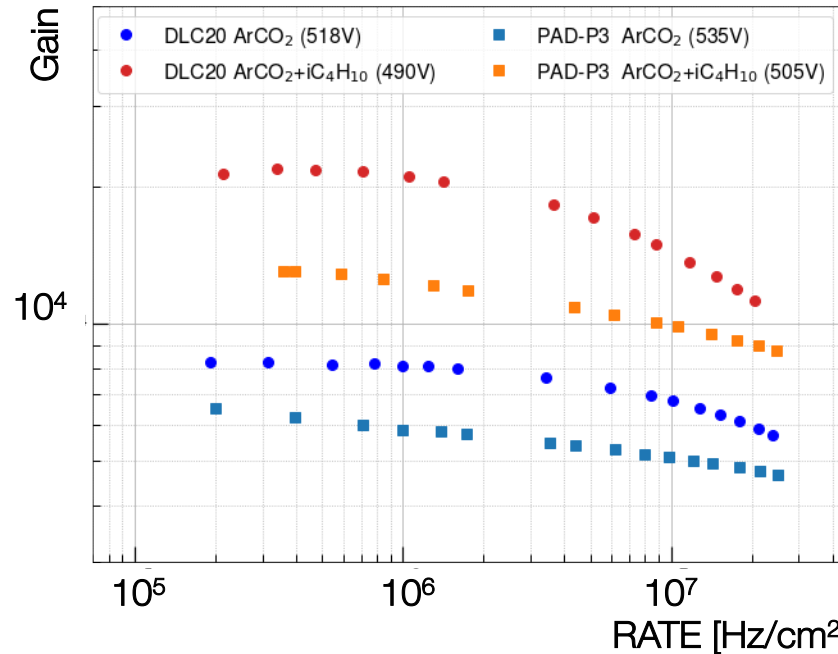
Pad-patterned



Double DLC



Rate capability $\sim 5\text{-}10 \text{ MHz/cm}^2$ at Gain $\sim 2 \times 10^4$



Concluding Remarks

- An intense and promising R&D activity is underway on resistive gas detectors (only a very limited and partial overview reported in this talk)
- As of today, not a single technology clearly predominant. R&D should proceed along multiple roads
- Need transfer of technology to **research institutes** and **PCB Industries**
- Today, there is a large interest in Diamond Like Carbon (DLC) coatings. The DLC production techniques must be, however, further advanced:
 - Uniformity and quality - Resistivity values from a few hundreds $k\Omega/\square$ to $G\Omega/\square$.
 - study of DLC mechanical etching (scrabbing) technologies to create high quality resistive patterns.
- Exploit sputtering production for different coatings (Cu/Cr clad DLC, B₄C, ITO for transparent MPGD)
- Beyond DLC, future R&D on **new resistive materials** must be pursued (e.g., **graphene**) and do not abandon the screen-printing technique (good for large simple production - control of resistivity needs R&D)
- **Fully resistive MPGD would further improve their stability.**
At the same time reducing the material budget (crucial challenge for the future)

BACKUP

RPCs have great potential for future development:

- good spatial and temporal resolution; low cost for large surfaces and a relatively simple construction

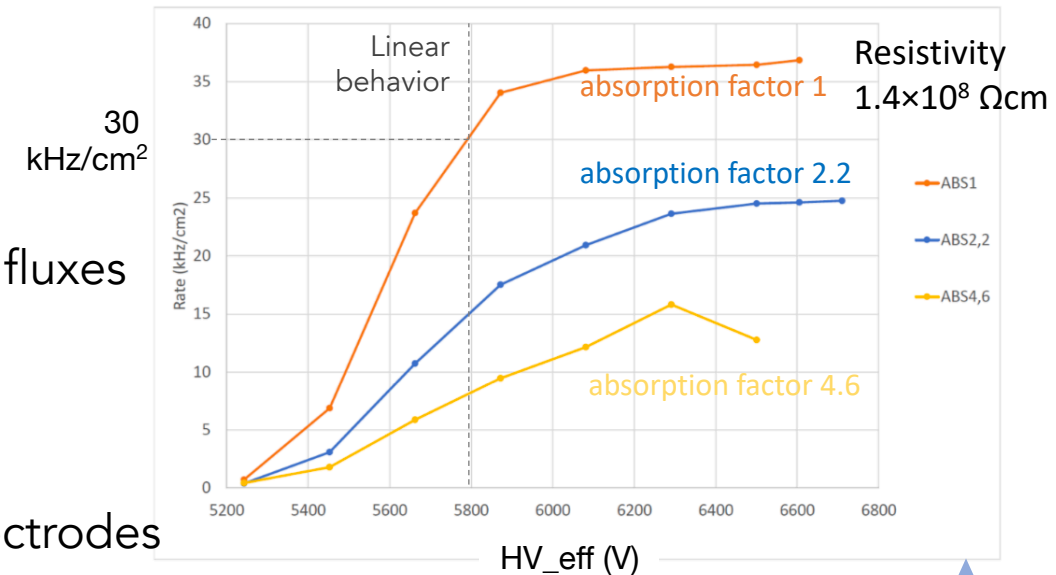
The main limitation of RPC is the rate capability.

Three MAIN approaches pursued:

- **New materials:**
 - optimization of resistivity AND to prevent ageing under high fluxes
- **New geometries (thin electrodes, multiple gaps)**
- **Low-noise FEE**

Among the ongoing developments: RPC with semiconducting electrodes

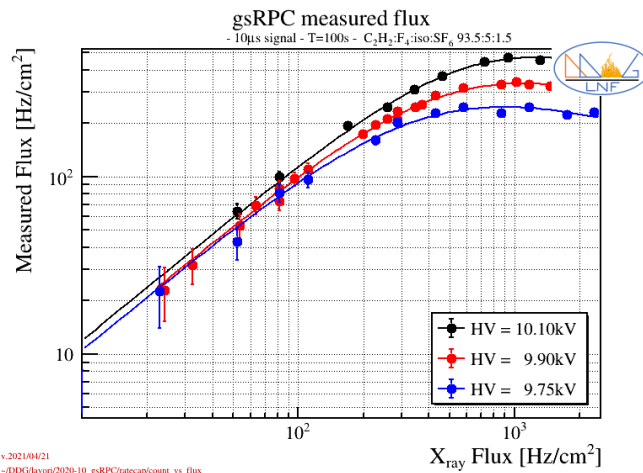
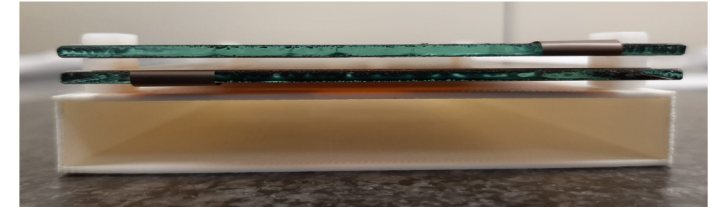
- The idea of using electronic semiconductors as RPC electrodes is mainly motivated by their lower resistivity which allows to increase the RPC rate capability
- Small size RPCs with Silicon and GaAs electrodes successfully tested. Rate capability $\sim 30\text{-}40$ kHz/cm² with excellent potentialities for higher rates [A. Rocchi et al 2019 JINST 14 C12005]



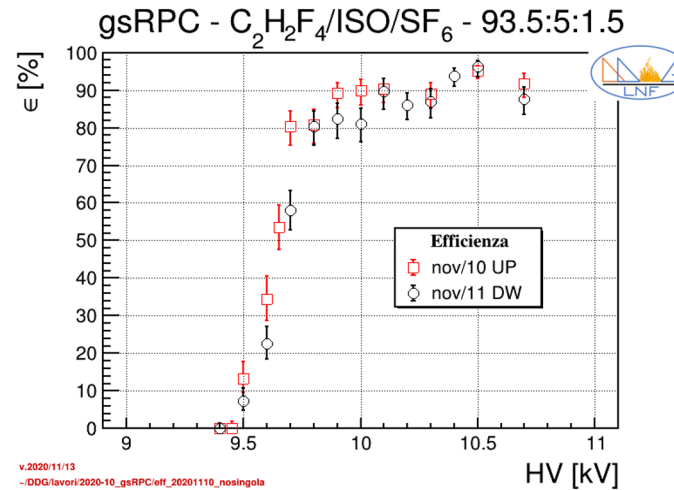
NEW: G. Bencivenni et al. Surface Resistive Plate Counter sRPC manufactured with DLC coating technique (see Backup slides) and P. Iengo Development of a resistive plate device with micro-pattern technique" (Screen Printing) NIM, A 958 (2020) 162779

Surface Resistive Plate Counter sRPC

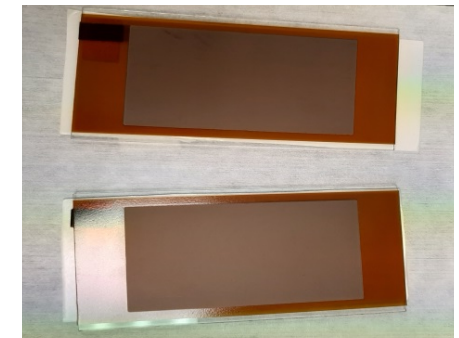
- The **sRPC** is based on **surface resistivity thin electrodes** (1-10 GΩ/sq) manufactured with **industrial DLC** coating techniques on flexible or semi-rigid supports,
- a completely different concept w.r.t. traditional RPCs characterized by volume resistivity



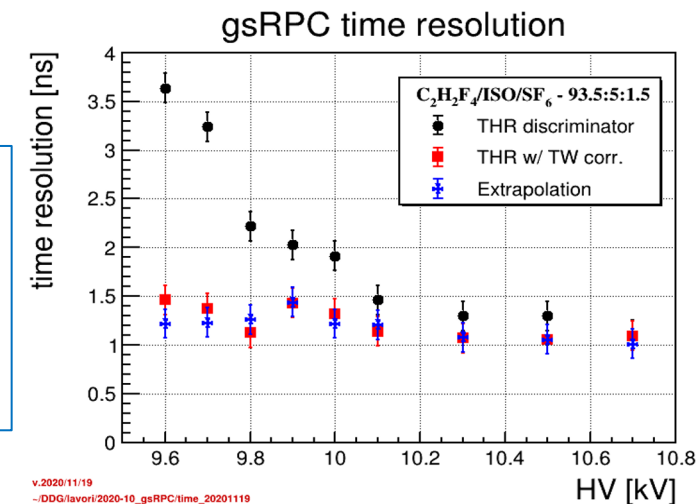
v.2021/04/21
--DDG/lavori/2020-10_gsRPC/ratecap/count_vs_flux



v.2020/11/13
--DDG/lavori/2020-10_gsRPC/eff_20201110_nosingola



- The detector can be operated in a stable and efficient way over a wide voltage range (>1 kV)
- Typical **time resolution of 1 ns**
- Rate capability of **1 kHz/cm²** (m.i.p. ~ 3 X-ray) obtained with a 2 mm gas gap
- Exploiting the technology developed for resistive MPGDs should allow the development of sRPC achieving very high particle rates (>10 kHz/cm²)



v.2020/11/19
--DDG/lavori/2020-10_gsRPC/time_20201119

Brevetto in Italia N. 10202000002359 (submitted to INFN 10 Sept 2019 - deposited to Ufficio Brevetti 6 Feb 2020)
INFN – "ELETTRODO PIANO A RESISTIVITÀ SUPERFICIALE MODULABILE E RIVELATORI BASATI SU DI ESSO."

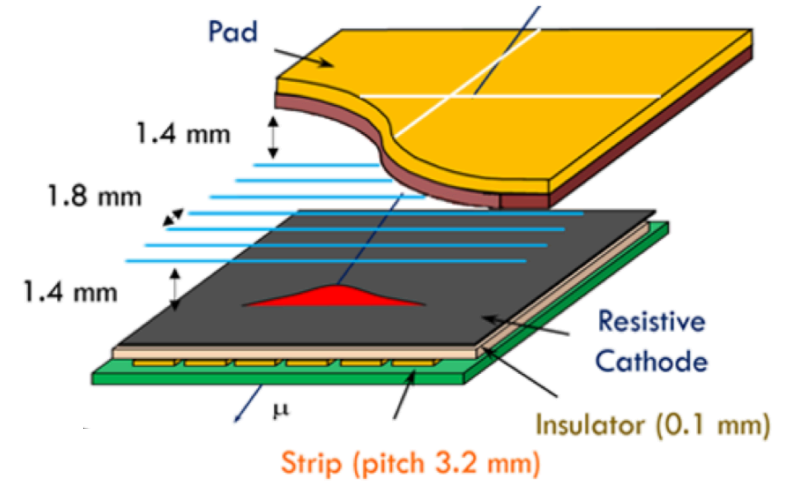
Thin Gap Chambers (TGC)

Successfully employed in large experiments
In ATLAS: "low-rate" and "high-rate" (sTGC)

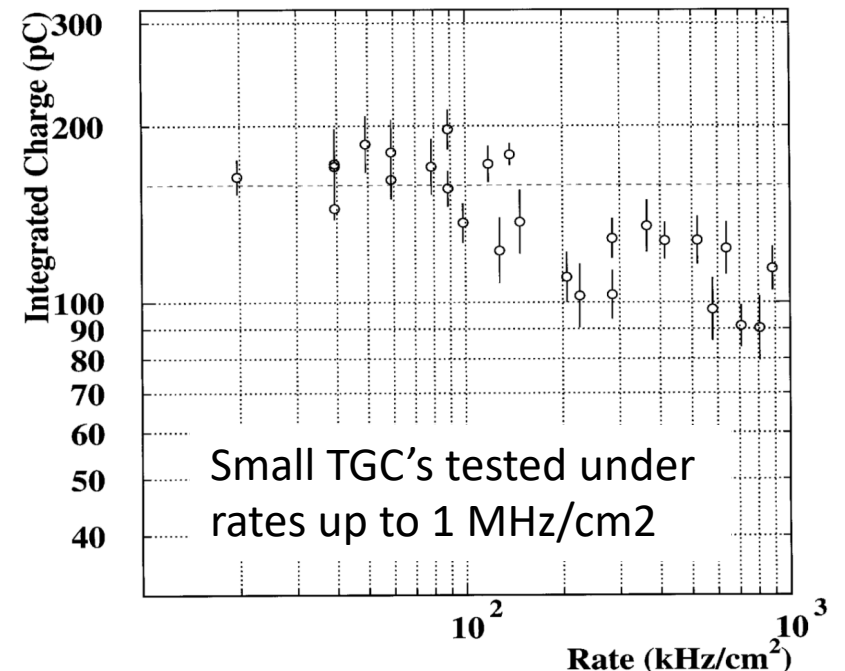
- CSC-like structure
- Anode wires sandwiched between 2 high resistive layers.
- Readout behind resistive layers (strips, pads)
- ATLAS **TGC** "low-rate" $O(\text{kHz}/\text{cm}^2)$: $R = 0.5$ and $1 \text{ M}\Omega/\text{sq}$
- ATLAS **small-strips TGC** "high-rate" (10 's kHz/cm^2):
 $R = 100$ and $200 \text{ k}\Omega/\text{sq}$

RATE CAPABILITY: up to $100 \text{ kHz}/\text{cm}^2$ for local irradiation

- limited to $30 \text{ kHz}/\text{cm}^2$ for **LARGE AREAS**
- Also limited by granularity \rightarrow high occupancy



Resistive layer applied by Carbon Spray



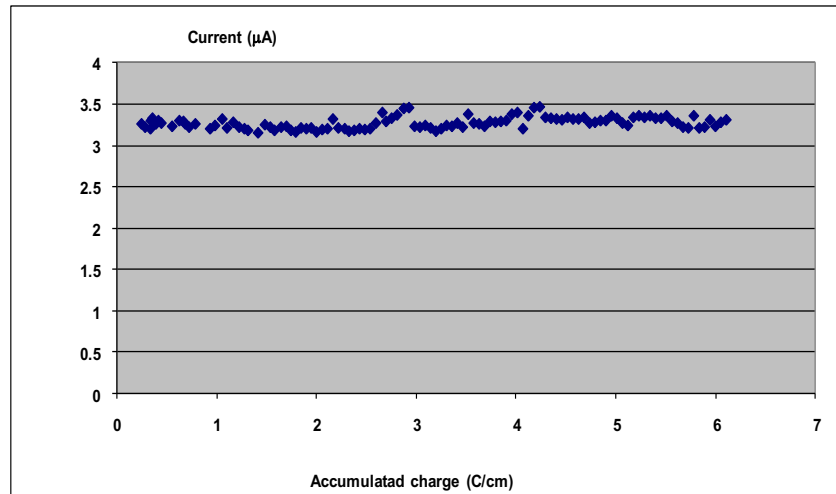
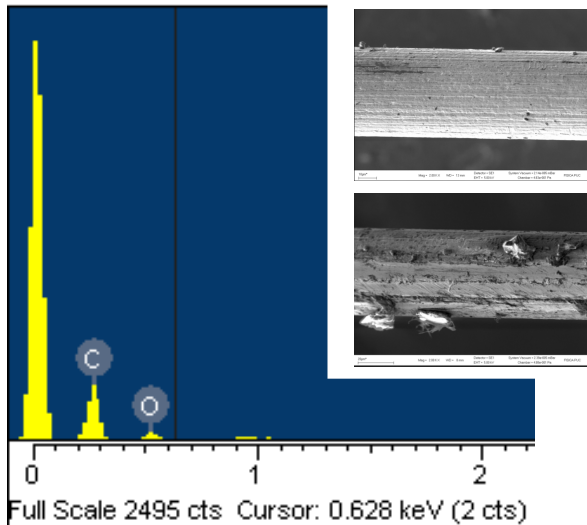
Thin Gap Chambers (TGC)

TGC STABILITY and AGEING

- Gas: CO₂ – n-Pentane (55%-45%): n-Pentane increases the ionization, while absorbing the photons in the avalanche.
- In the TGC has proven to perform “much better” than isobutane
- A small chamber has accumulated 6 Coulomb/cm, without any deterioration= 20 years at HL-LHC with safety factor 5.

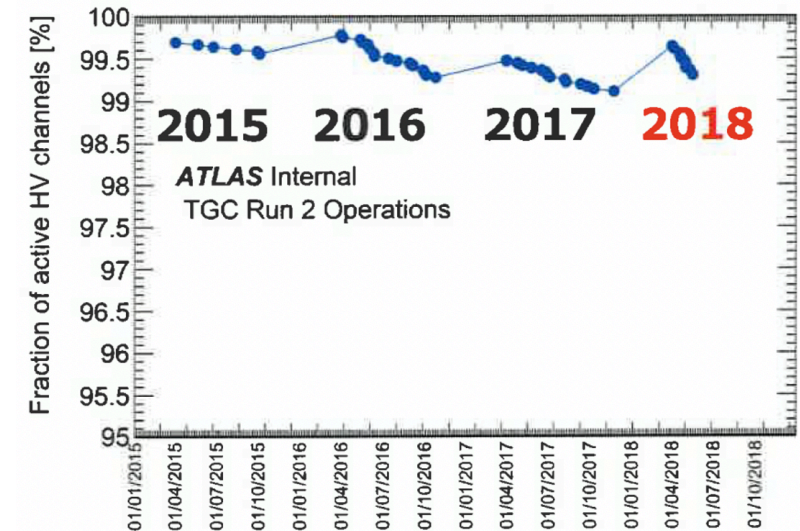
Anode and cathodes analyzed:
Deposits: mainly Carbon and Oxygen

No signs of ageing



IN ATLAS

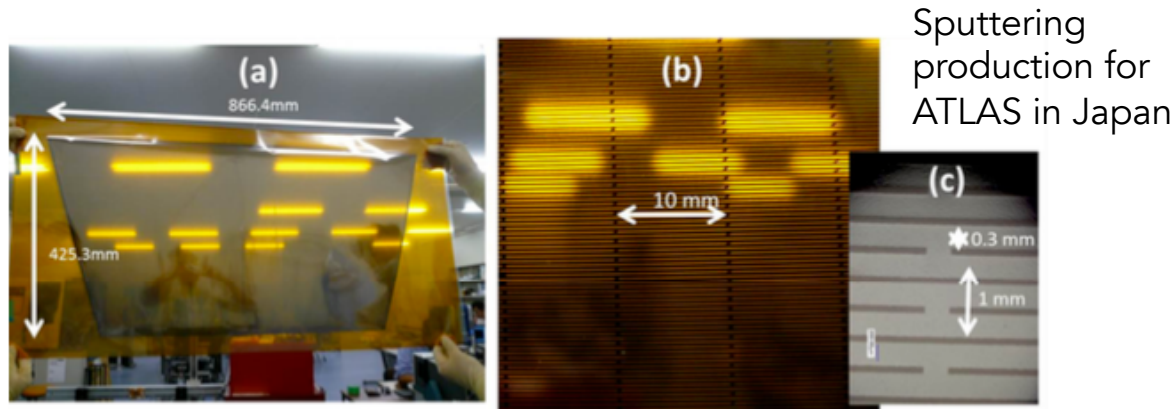
- 4,000 large area TGC's
- Very stable, though with several trips during physics runs
- >99% active HV channels



The ATLAS Resistive Micromegas

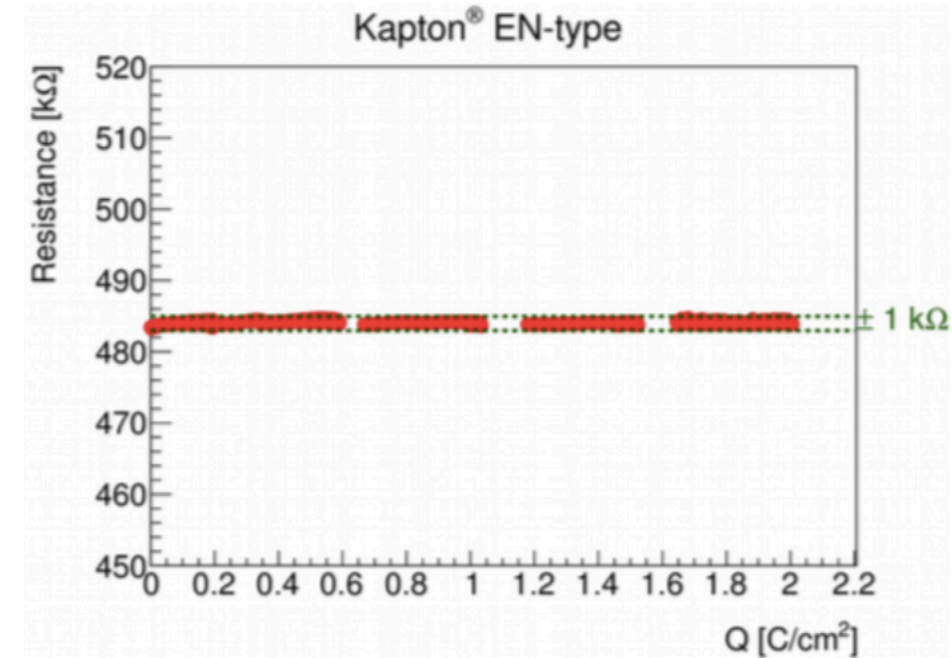
Choice of the technique for the resistive layer

- DLC sputtering Vs screen-printing
- Both evaluated and considered valid for ATLAS MM



A. Ochi, PoS(TIPP2014)351

Choice finally made on **screen printing technique**, mostly motivated by the lower cost, also by some evidence on mechanical poor DLC adhesion after treatment (liftoff) to pattern the (interconnected) strips



Resistive screen-printing on Kapton
Measurement of stability done up to 2 C/cm² equivalent charge
applying a DC Voltage in order to induce a continuous current flow over the resistive surface (analogous to plot for DLC on slide 11)

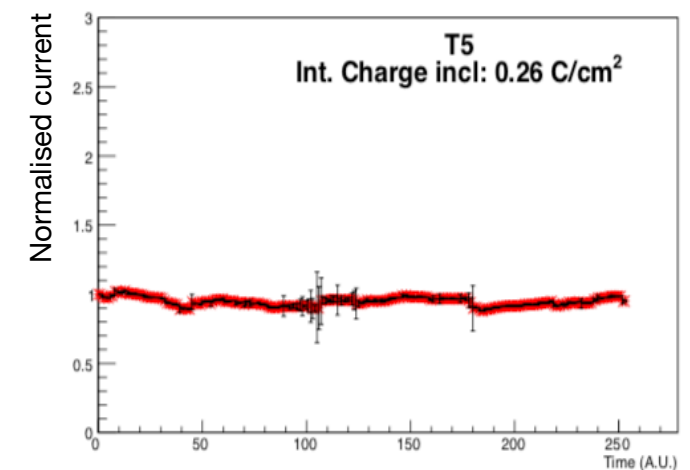
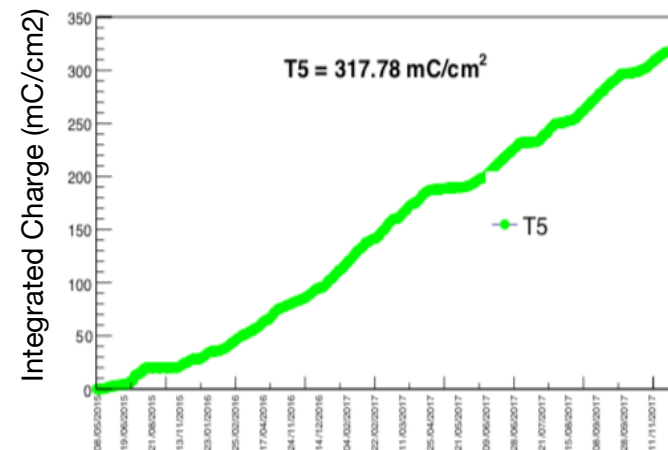
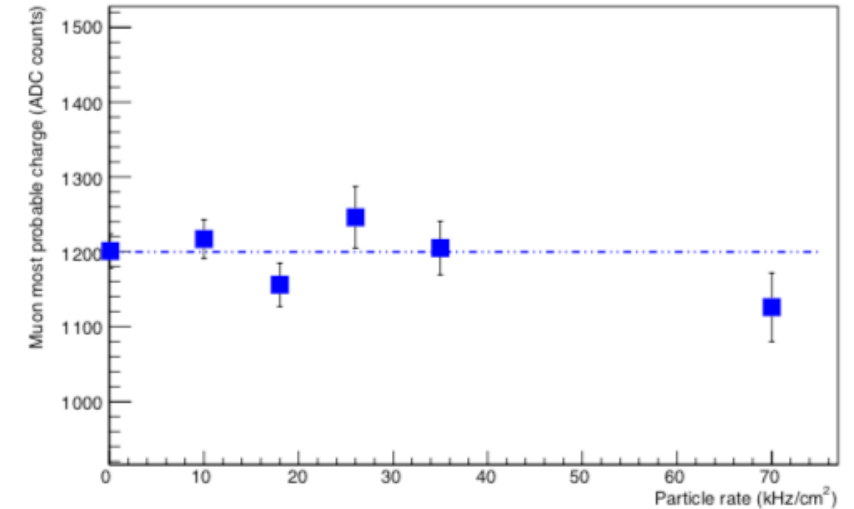
Resistive Micromegas – the ATLAS Experience

RATE CAPABILITY AND AGEING

- Studies carried out at GIF++ at CERN (14TBq Cesium source) [ref]
- Two Small size MM Resistive Prototypes (“ATLAS style”)
 - Resistive strips with \sim few $M\Omega/sq$
 - Operated with the “ageing safe” gas mixture Ar/CO₂ 93/7

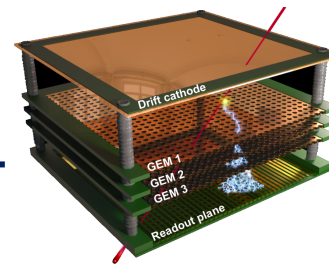
- RATE CAPABILITY: measured gain drop of \sim 10% at 70 kHz/cm²
- In 2015-2017 more than 0.3 C/cm² have been accumulated (more than what expected in 10 years of HL-LHC in the NSW)

→ no ageing effects have been observed in gas gain, efficiency and current stability

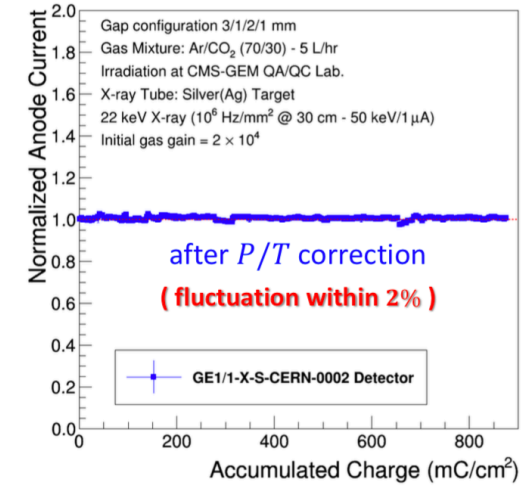


GEM

- The main solution adopted to obtain high gain, high performance with GEM is the multi-stage amplification scheme
 - E.g., Triple GEM successfully employed in many experiments and now Large area T-GEM under installation in CMS and ALICE (TPC) at LHC
 - Good stability, high gain ($>2 \times 10^4$), high-rate capability $\mathcal{O}(\text{MHz}/\text{cm}^2)$
 - Yet, construction not straightforward, especially for large surfaces



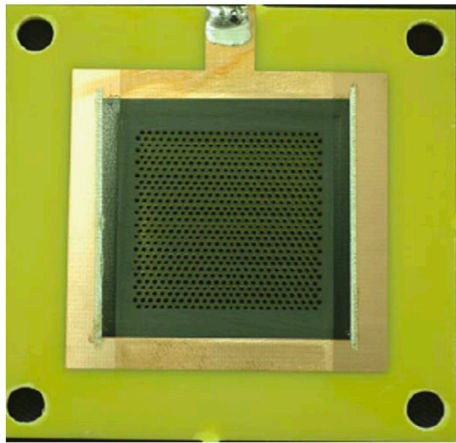
CMS-GEM
MEO
(F. Fallavollita
PhD Thesis)



NO aging observed up to $\sim 875 \text{ mC}/\text{cm}^2$

R&D on Resistive GEM

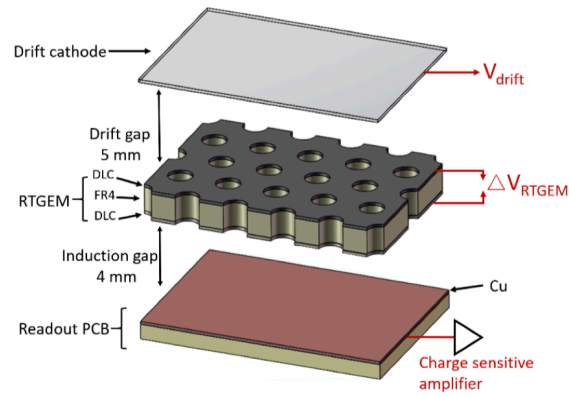
Resistive Thick GEM



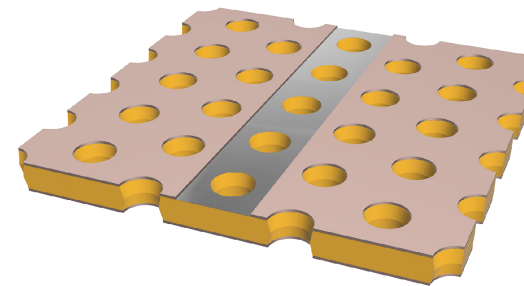
R. Oliveira, V. Peskov, et al. NIM A576 (2007) 362
And <https://ieeexplore.ieee.org/stamp/stamp.jsp?tp=&arnumber=5658074>

RETGEM with DLC

G. Song *et al* 2020 JINST 15 P11013

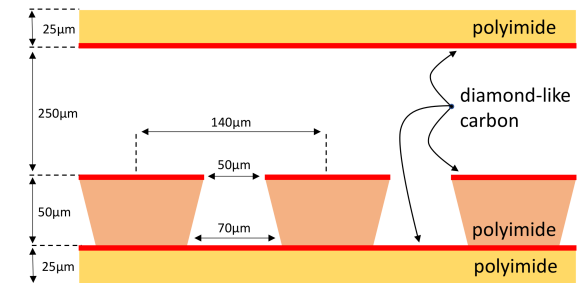


DLC layers in sector gaps preserve the electric field line uniformity



F. Sauli "RESTORING EFFICIENCY IN GEM SECTOR SEPARATIONS"
<https://indico.cern.ch/event/843711/>

FTM (see talk by P. Verwilligen)
Fast Timing Mpgd

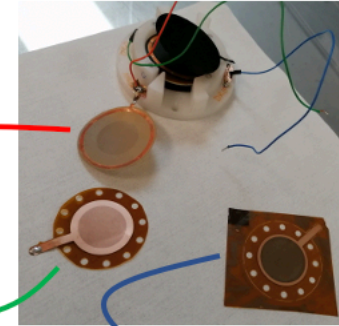


FTM effort: Full resistive kapton 50 μm with DLC
Next step: GEM

FTM – R&D on GEM resistive foils

From P. Verwilligen

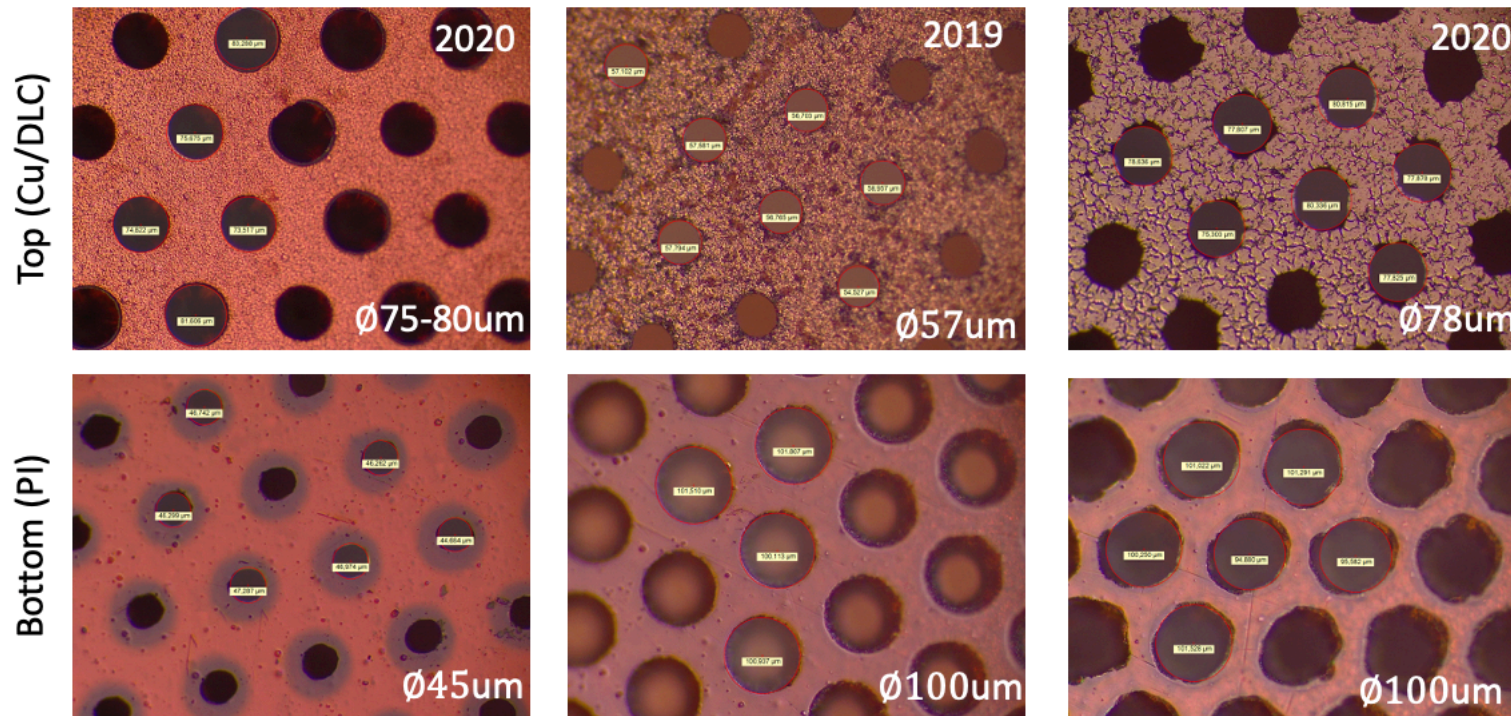
Quality of Amplification Foils (Cond'ive & Res'ive)



Conductive Foil

Resistive Foil (1st prod)

Resistive Foil (2nd prod)

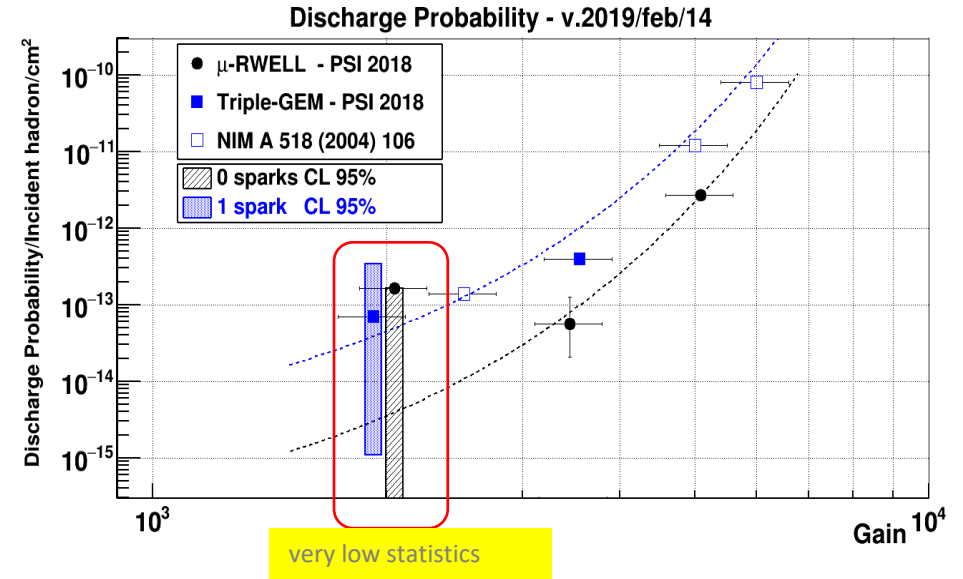
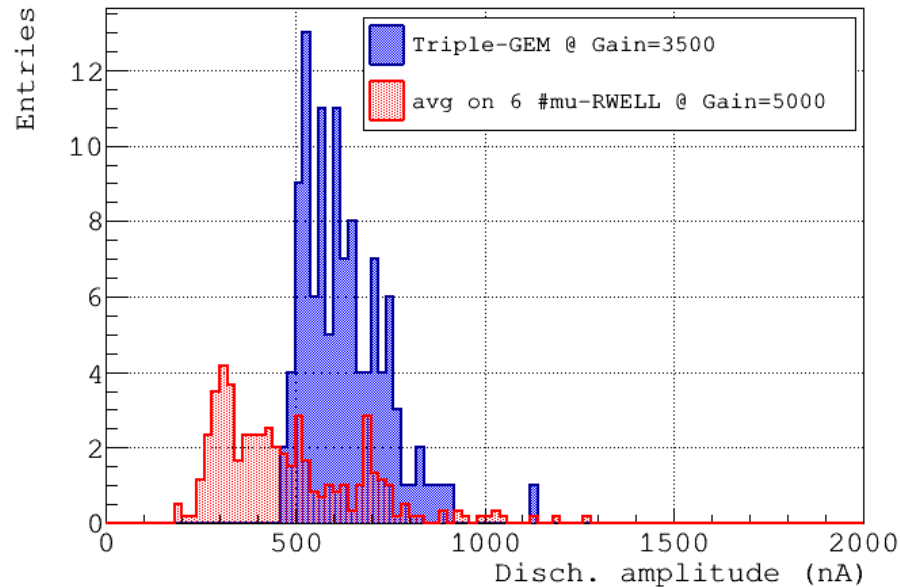


Discharge studies – μ RWELL Vs Triple-GEM

The discharge probability measured @ PSI and compared with the measurement done with GEM at the same time and in the 2004 (same gas mixture - $Ar:CO_2:CF_4 = 45:15:40$).

Measurement conditions:

- current mode
- $p_{\pi^+} = 270 \text{ MeV}/c$ π^+ beam \oplus 3.5% proton



A “discharge” defined as the current spike exceeding the steady current level correlated to the particle flux ($\sim 90 \text{ MHz}$ on a $\sim 5 \text{ cm}^2$ beam spot size).

The discharge probability for μ -RWELL comes out to be slightly lower than the one measured for GEM. While its discharge amplitude seems to be lower than the one measured for GEM.